

<b>Notice of References Cited</b>	Application/Control No. 10/721,750	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner Christine M. Behncke	Art Unit 3661	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,161,055	12-2000	Pryor, Timothy R.	700/175
*	B	US-6,414,711	07-2002	Arimatsu et al.	348/86
*	C	US-6,763,283	07-2004	Murakami, Naoyuki	700/259
*	D	US-6,859,683	02-2005	Parker et al.	700/259
*	E	US-2002/0171551	11-2002	Eshelman et al.	340/573.1
*	F	US-2005/0050942	03-2005	Schmitt, Edward A.	073/007
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002-123306	04-2002	Japan	Koichi	G05B 19/18
	O	JP06-249678	09-1994	Japan	Takeshi	G01D 9/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine generated English translations of JP2002-123306 and JP06-249678 provided by Japanese Patent Office website.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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